

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. : ST 10015		SERIAL NO. 09/813,240	
<div style="display: flex; align-items: center;"> <div style="border: 1px solid black; border-radius: 50%; padding: 5px; text-align: center; margin-right: 10px;"> OIPE JUN 26 2003 PATENT & TRADEMARK OFFICE 197 </div> <div> LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary) </div> </div>				APPLICANT: von Ammon et al.			
FILING DATE: March 20, 2001				GROUP: 2811			

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
<i>[Signature]</i>	AA	5,935,320	8/10/99	Graef et al.			
<i>[Signature]</i>	AB	5,505,157	4/9/96	Hara et al.			
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FOREIGN PATENT DOCUMENTS								
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION		
						YES	NO	
<i>[Signature]</i>	AL	0829559	3/18/98	Europe				
<i>[Signature]</i>	AM	0170788	2/12/86	Europe				
<i>[Signature]</i>	AN	1365724	9/4/74	United Kingdom				
<i>[Signature]</i>	AO	2147514	3/30/72	Germany				
	AP							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)			
<i>[Signature]</i>	AR		Hara A. et al., "Hydrogen in As-Grown Czoch-ralski Silicon Crystals", 1993, p. 1014-1016
<i>[Signature]</i>	AS		Hara A. et al., "Influence of Grown-in Hydrogen on Thermal Donor Formation ...", 1994, p. 5571-5584
	AT		Iino E. et al., "Cavities owing to hydrogen in Si single crystals ...", Vol. B36, 1996, p. 146-149

EXAMINER J. M. ONDT <i>[Signature]</i>	DATE CONSIDERED Jan 4 '02.
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>[Signature]</i>	AR		Patent Abstract of Japan corresponding to JP 61 178 495
<i>[Signature]</i>	AS		Patent Abstract of Japan corresponding to JP 07 126 094 -
<i>[Signature]</i>	AT		Patent Abstract of Japan corresponding to JP 11 189 495

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>JPL</i>	AA	4,210,486	7/1/80	Schmidt et al.			
<i>JPL</i>	AB	5,641,353	6/24/97	Hara et al.			
<i>JPL</i>	AC	3,660,062	5/2/72	Veller			
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							YES	NO
<i>JPL</i>	AL	0725169	8/7/96	Europe ✓				
<i>JPL</i>	AM	3545383	7/12/87	Germany ✓				
<i>JPL</i>	AN	99/57344	11/11/99	PCT International				
	AO							
	AP							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>JPL</i>	AR		English Derwent Abstract AN 1996-356122 [36] corresponding to EPO 725169
<i>JPL</i>	AS		E. Iino et al., Materials Science and Engineering 336 (1996) 146-149
<i>JPL</i>	AT		English Derwent Abstract AN 1987-186078 [27] corresponding to DE 3545383

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<i>JPM</i>	AR		<i>English Derwent Abstract AN 2000-023590 [02] corresponding to WO 99/57344</i>
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	AT		

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